

RU7550R-VB Datasheet

N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS}	80	V		
R _{DS(on)} V _{GS} = 10 V	7	mΩ		
$R_{DS(on)}$ $V_{GS} = 4.5 \text{ V}$	9	mΩ		
I _D	100	Α		
Configuration	Single			

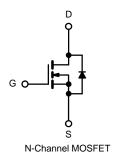
FEATURES

- Trench Power MOSFET
- \bullet 100 % R_g and UIS Tested

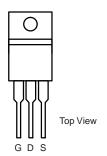


APPLICATIONS

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



220	
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ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless	otherwise note	ed)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	80	V	
Gate-Source Voltage	V _{GS}	± 20	□	
	T _C = 25 °C		100a	
Continuous Dunin Comment /T 150 °C	T _C = 70 °C	1 . 🗆	85 ^a	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	28.6 ^{b, c}	
	T _A = 70 °C		24.9 ^{b, c}	
Pulsed Drain Current (t = 100 μs)		I _{DM}	350	Α Α
Continuous Constant District Constant	T _C = 25 °C		80 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	4.5 ^{b, c}	
Single Pulse Avalanche Current		I _{AS}	30	
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	45	mJ
Maximum Power Dissipation	T _C = 25 °C		180	
	T _C = 70 °C		120	,,,
	T _A = 25 °C	P _D	5 ^{b, c}	W
	T _A = 70 °C		3.2 ^{b, c}	
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Marrian un lun ation to Anabianta	t ≤ 10 sec	R_{thJA}	15	18	°C/W	
Maximum Junction-to-Ambient ^a	Steady State		40	50		
Maximum Junction-to-Case		R _{thJC}	0.85	1.1		

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.



SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$, u	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	- Cynnbon	1001 00110110110		.,,,,	Maxi	J 0
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			37		-
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.1		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	2.0		3.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
· ·		V _{DS} = 80 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	85			Α
	D(GII)	V _{GS} = 10 V, I _D = 20 A		7		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 15 A		7. 5		mΩ
	36(6.1)	V _{GS} = 4.5 V, I _D = 10 A		9		1
Forward Transconductancea	g _{fs}	V _{DS} = 10 V, I _D = 20 A		60		S
Dynamic ^b				L	L	
Input Capacitance	C _{iss}			3855		
Output Capacitance	C _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1120		pF
Reverse Transfer Capacitance	C _{rss}			376		
	Qg	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		35.5		nC
Total Gate Charge		$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22		
				18		
Gate-Source Charge	Q_{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		5.3		
Gate-Drain Charge	Q_{gd}			7.3		
Output Charge	Q _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		57	86	
Gate Resistance	R_g	f = 1 MHz	0.5	1.3	2	Ω
Turn-On Delay Time	t _{d(on)}			12	24	
Rise Time	t _r	$V_{DD} = 40 \text{ V}, R_L = 4 \Omega$		8	16	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		32	64	
Fall Time	t _f			7	14	ne
Turn-On Delay Time	t _{d(on)}			14	28	ns
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$		11	22	
Turn-Off DelayTime	t _{d(off)}	$I_D\cong~10~A,V_{GEN}=6.0~V,R_g=1~\Omega$		30	60	
Fall Time	t _f			8	16	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			75	Α
Pulse Diode Forward Current (t = 100 μs)	I _{SM}				150	
Body Diode Voltage	V_{SD}	I _S = 5 A		0.76	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			38	75	ns
Body Diode Reverse Recovery Charge	Q_{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		36	70	nC
Reverse Recovery Fall Time	t _a	₁ = 10 / 1, α, α = 100 / 1 μο, 1 J = 20 0		19		ns
Reverse Recovery Rise Time	t _b			19		

Notes

- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

0. 010

0. 009

0.008

0.007

0.006

0.005

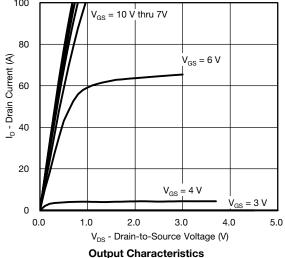
0

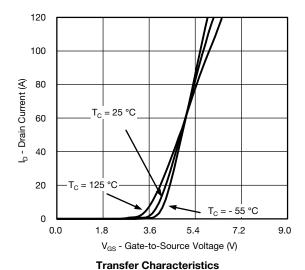
90

R_{DS(on)} - On-Resistance (Ω)

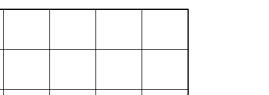


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



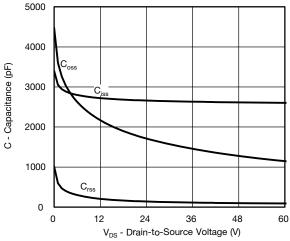




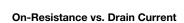


120

130



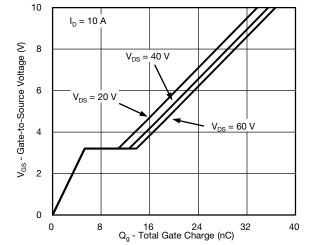
Capacitance



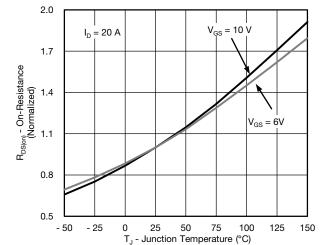
110

100

 $V_{GS} = 10 \text{ V}$



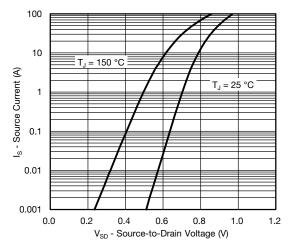
Gate Charge



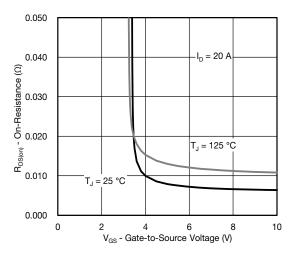
On-Resistance vs. Junction Temperature



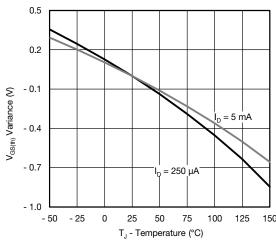
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



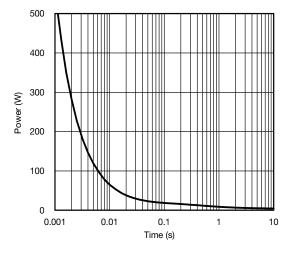
Source-Drain Diode Forward Voltage



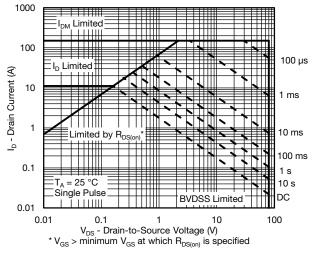
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



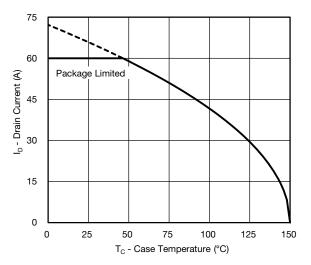
Single Pulse Power, Junction-to-Ambient



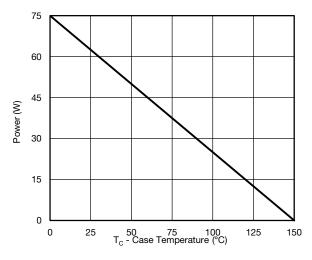
Safe Operating Area, Junction-to-Ambient



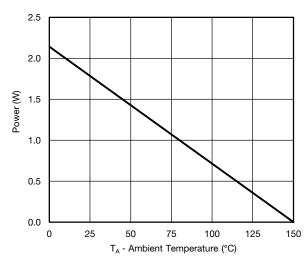
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





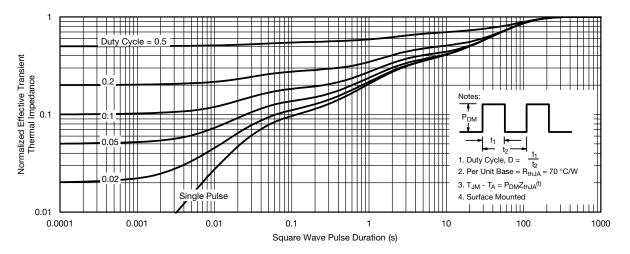


Power, Junction-to-Ambient

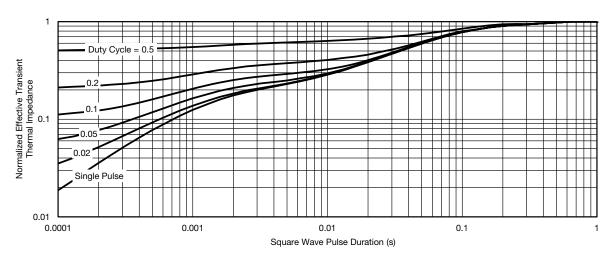
^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



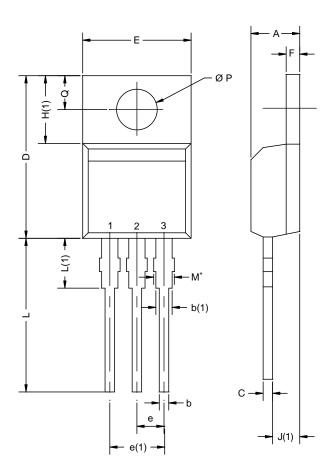
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12					

DWG: 5471

Notes

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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